


<b>Search Notes</b> 	<b>Application/Control No.</b> 10606104	<b>Applicant(s)/Patent Under Reexamination</b> WANG ET AL.
	<b>Examiner</b> Nguyen, Phillip	<b>Art Unit</b> 2828

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search (see search history printout)	6/13/07	PN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner